

8M × 32-Bit Dynamic RAM Module SMALL OUTLINE MEMORY MODULE

HYM 328000GD-50/-60

Preliminary Information

- 8 388 608 words by 32-bit organization
- Fast access and cycle time
 - 50 ns access time
 - 95 ns cycle time (-50 version)
 - 60 ns access time
 - 110 ns cycle time (-60 version)
- Fast page mode capability with
 - 35 ns cycle time (-50 version)
 - 40 ns cycle time (-60 version)
- Single + 3.3 V (± 0.3 V) supply
- Low power dissipation
 - max. 2016 mW active (-50 version)
 - max. 1728 mW active (-60 version)

LVC MOS – 3.6 mW standby
LVTTL – 28.8 mW standby
- $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh, $\overline{\text{RAS}}$ -only-refresh, Self Refresh
- 4 decoupling capacitors mounted on substrate
- All inputs, outputs and clock fully TTL compatible
- 72 pin, dual read-out, one bank, Small Outline DIMM Module
- Utilizes four 8M × 8 -DRAMs (HYB 3165800T)
- 4096 refresh cycles / 64 ms
- Gold contact pad

The HYM 328000GD -50/-60 is a 32 MByte DRAM module organized as 8 388 608 words by 32-bit in a 72-pin, dual read-out, small outline package comprising four HYB 3165800T 8M x 8 DRAMs in 500 mil wide TSOP-II-34 - packages mounted together with four 0.2 µF ceramic decoupling capacitors on a PC board. Each HYB 3165800T is described in the data sheet and is fully electrically tested and processed according to Siemens standard quality procedure prior to module assembly. After assembly onto the board, a further set of electrical tests is performed.

The density and speed of the module can be detected by the use of presence detect pins.

These modules are ideal for portable systems applications where high memory capacity is needed.

Ordering Information

Type	Ordering Code	Package	Descriptions
HYM 328000GD -50	on request	L-DIM-72-2	50 ns DRAM module
HYM 328000GD -60	on request	L-DIM-72-2	60 ns DRAM module

Pin Names

A0-A11	Row Address Input
A0-A10	Column Address Inputs
DQ0 - DQ31	Data Input/Output
RAS0, RAS2	Row Address Strobe
CAS0 - CAS3	Column Address Strobe
WE	Read / Write Input
Vcc	Power (+3.3 Volt)
Vss	Ground
PD1 - PD7	Presence Detect Pins
N.C.	No Connection

Presence-Detect and ID-pin Thru Table *:

Module	PD1	PD2	PD3	PD4	PD5	PD6	PD7
HYM 328000GD -50	VSS	VSS	NC	NC	VSS	VSS	NC
HYM 328000GD -60	VSS	VSS	NC	NC	NC	NC	NC

note: PD1 .. PD4 : configuration
 PD5 .. PD6 : speed
 PD7 : refresh mode (NC = normal refresh)

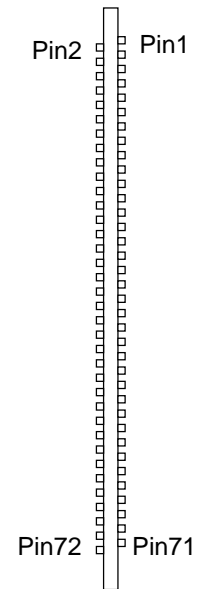
* according to JEDEC letter ballot JC-42.5-95 Item #646/651

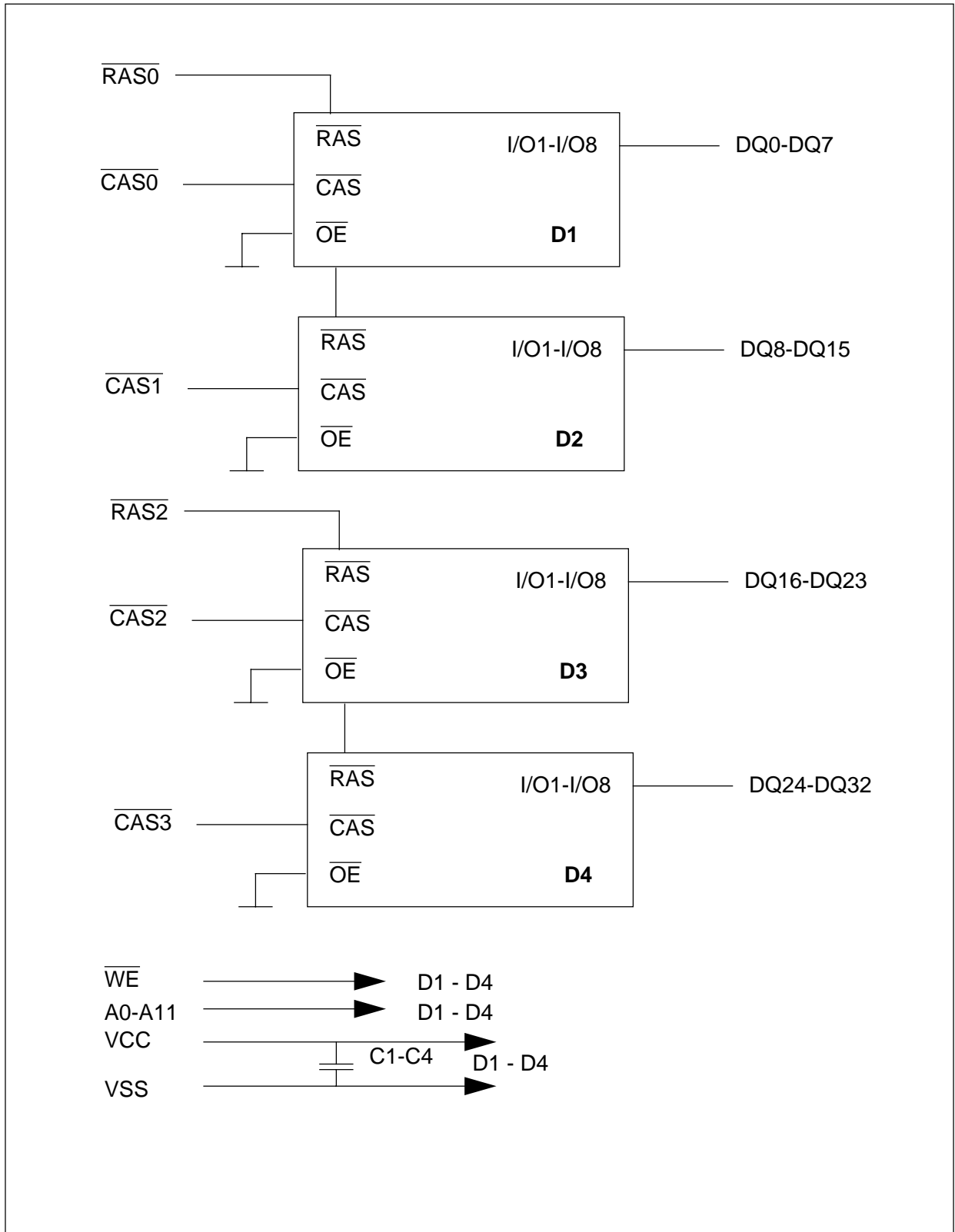
Pin Configuration

PIN	Name	PIN	NAME	PIN	NAME	PIN	NAME
1	VSS	37	DQ16	2	DQ0	38	DQ17
3	DQ1	39	VSS	4	DQ2	40	CAS0
5	DQ3	41	CAS2	6	DQ4	42	CAS3
7	DQ5	43	CAS1	8	DQ6	44	RAS0
9	DQ7	45	NC	10	VCC	46	NC
11	PD1	47	WRITE	12	A0	48	NC
13	A1	49	DQ18	14	A2	50	DQ19
15	A3	51	DQ20	16	A4	52	DQ21
17	A5	53	DQ22	18	A6	54	DQ23
19	A10	55	NC	20	NC	56	DQ24
21	DQ8	57	DQ25	22	DQ9	58	DQ26
23	DQ10	59	DQ28	24	DQ11	60	DQ27
25	DQ12	61	VCC	26	DQ13	62	DQ29
27	DQ14	63	DQ30	28	A7	64	DQ31
29	A11	65	NC	30	VCC	66	PD2
31	A8	67	PD3	32	A9	68	PD4
33	NC	69	PD5	34	RAS2	70	PD6
35	DQ15	71	PD7	36	NC	72	VSS

Front Side

Back Side





Block Diagramm

Absolute Maximum Ratings ¹⁾

Operating temperature range.....	0 to 70 °C
Storage temperature range.....	- 55 to 150 °C
Soldering temperature.....	260 °C
Soldering time.....	10 s
Input/output voltage.....	-0.5 to min (V _{CC} +0.5,4.6) V
Power supply voltage.....	-0.5V to 4.6 V
Power dissipation.....	1.0 W
Data out current (short circuit).....	50 mA

DC Characteristics

$T_A = 0$ to 70 °C, $V_{SS} = 0$ V, $V_{CC} = 3$ V \pm 0.3 V

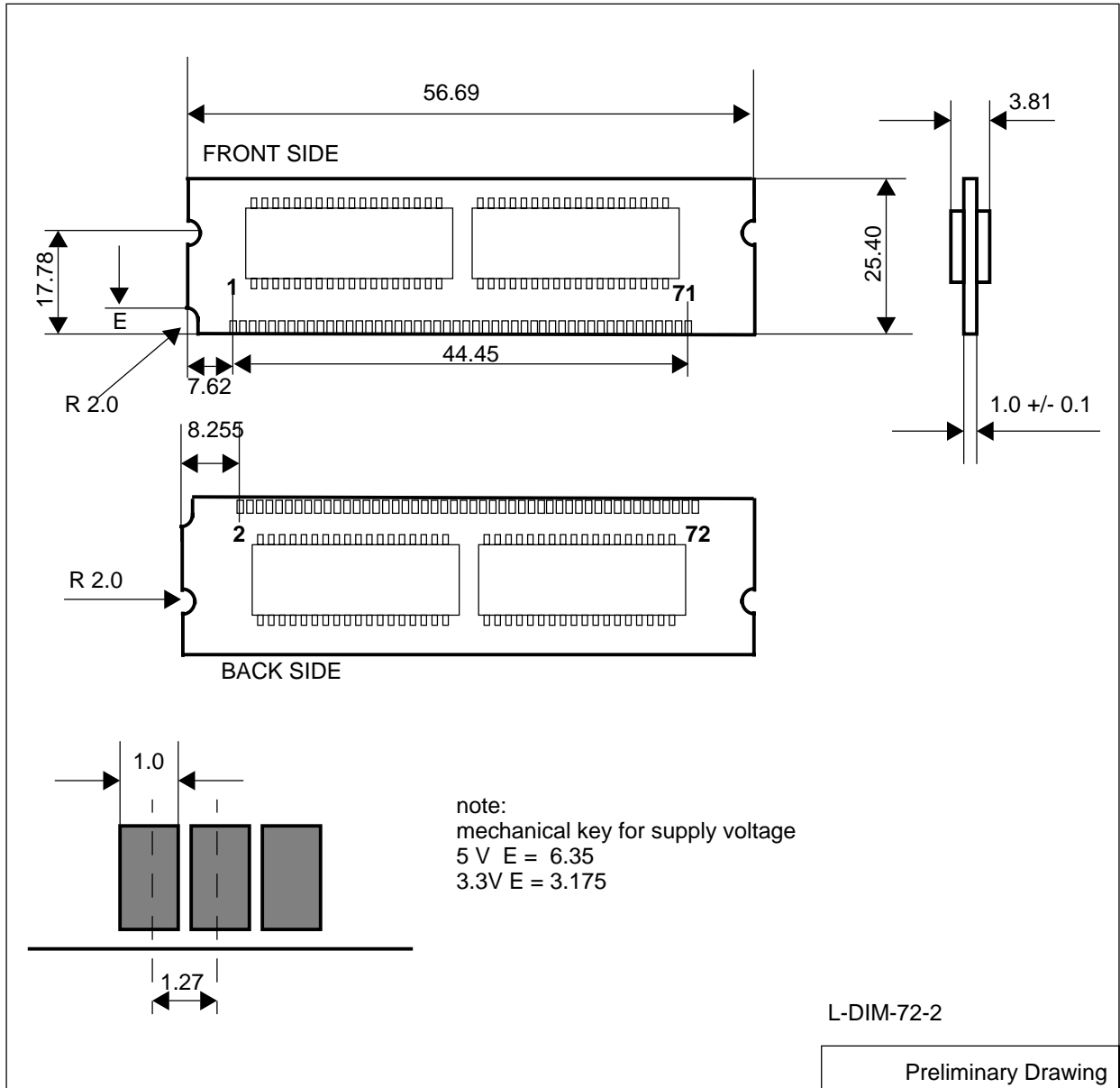
Parameter	Symbol	Limit Values		Unit	Note
		min.	max.		
Input high voltage	V_{IH}	2.0	$V_{CC}+0.3$	V	2)
Input low voltage	V_{IL}	- 0.3	0.8	V	2)
Output high voltage (LVTTL) Output „H“ level voltage (I _{out} = -2mA)	V_{OH}	2.4	-	V	
Output low voltage (LVTTL) Output „L“ level voltage (I _{out} = +2mA)	V_{OL}	-	0.4	V	
Output high voltage (LVCMOS) Output „H“ level voltage (I _{out} = -100uA)	V_{OH}	$V_{CC}-0.2$	-	V	6)
Output low voltage (LVCMOS) Output „L“ level voltage (I _{out} = +100uA)	V_{OL}	-	0.2	V	6)
Input leakage current, any input (0 V < V_{in} < V_{CC} , all other pins = 0 V)	$I_{I(L)}$	- 10	10	μA	
Output leakage current (DO is disabled, 0 V < V_{out} < V_{CC})	$I_{O(L)}$	- 10	10	μA	
Average V_{CC} supply current: -50 ns version -60 ns version (\overline{RAS} , \overline{CAS} , address cycling: t _{RC} = t _{RC} min.)	I_{CC1}	-	560 480	mA mA	3) 4) 5)
Standby V_{CC} supply current ($\overline{RAS}=\overline{CAS}=V_{IH}$)	I_{CC2}	-	8	mA	-
Average V_{CC} supply current, during RAS-only refresh cycles: -50 ns version -60 ns version (RAS cycling: $\overline{CAS} = \overline{VIH}$: t _{RC} = t _{RC} min.)	I_{CC3}	-	560 480	mA mA	3) 5)

DC Characteristics (cont'd)

$T_A = 0$ to 70 °C, $V_{SS} = 0$ V, $V_{CC} = 3$ V \pm 0.3 V

Parameter	Symbol	Limit Values		Unit	Note
		min.	max.		
Average V_{CC} supply current, during fast page mode: -50 ns version -60 ns version ($\overline{RAS} = V_{IL}$, \overline{CAS} , address cycling: $t_{PC}=t_{PC}$ min.)	I_{CC4}	–	340 300	mA mA	3) 4) 5)
Standby V_{CC} supply current ($\overline{RAS}=\overline{CAS}= V_{CC}-0.2V$)	I_{CC5}	–	800	A	–
Average V_{CC} supply current, during \overline{CAS} -before- \overline{RAS} refresh mode: -50 ns version -60 ns version (\overline{RAS} , \overline{CAS} cycling: $t_{RC} = t_{RC}$ min.)	I_{CC6}	–	560 480	mA mA	3) 4)
Self Refresh Current Average Power Supply Current during Self Refresh. (CBR cycle with $t_{RAS}>TRASS_{min}$, \overline{CAS} held low, $\overline{WE} = V_{CC}-0.2V$, Address and $D_{in}=V_{CC}-0.2V$ or $0.2V$)	I_{CC7}	–	800	A	

SO-DIMM PACKAGE OUTLINES



VAKAT